# STFU13N60M2



TO-220FP

ultra narrow leads

С

S(3)

Figure 1: Internal schematic diagram

### N-channel 600 V, 0.35 Ω typ., 11 A MDmesh<sup>™</sup> M2 Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data

## Features

Order code	VDS @ TJmax	RDS(on) max	ID
STFU13N60M2	650 V	0.38 Ω	11 A

- Extremely low gate charge
- Lower R<sub>DS(on)</sub> x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

### **Applications**

• Switching applications

### Description

This device is an N-channel Power MOSFET developed using MDmesh<sup>™</sup> M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

#### Table 1: Device summary

AM15572v1\_no\_tab

Order code	Marking	Package	Packaging
STFU13N60M2	13N60M2	TO-220FP ultra narrow leads	Tube

G(1)

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This is information on a product in full production.

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## 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	± 25	V
ID	Drain current (continuous) at $T_C = 25 \text{ °C}$	11 <sup>(1)</sup>	А
lъ	Drain current (continuous) at T <sub>C</sub> = 100 °C	7	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	44	А
Ртот	Total dissipation at $T_C = 25 \text{ °C}$	25	W
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; $T_c$ = 25 °C)	2500	V
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
dv/dt (4)	MOSFET dv/dt ruggedness	50	v/ns
T <sub>stg</sub>	Storage temperature	- 55 to 150	°C
Tj	Max. operating junction temperature	- 55 10 150	C

#### Notes:

<sup>(1)</sup>Limited by maximum junction temperature.

<sup>(2)</sup>Pulse width limited by safe operating area.

 $^{(3)}I_{SD} \leq$  11 A, di/dt  $\leq$  400 A/µs; V\_DSpeak < V(BR)DSS, V\_DD = 400 V  $^{(4)}V_{DS} \leq$  480 V

#### Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	5	°C/W
Rthj-amb	Thermal resistance junction-ambient max		°C/W

#### Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )	2.8	А
Eas	Single pulse avalanche energy (starting $T_j = 25^{\circ}C$ , $I_D = I_{AR}$ ; $V_{DD} = 50 \text{ V}$ )	125	mJ



## 2 Electrical characteristics

(T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V(BR)DSS	Drain-source breakdown voltage	$I_{D} = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	600			V
1	Zero gate voltage	V <sub>DS</sub> = 600 V			1	μA
IDSS	drain current (V <sub>GS</sub> = 0)	$V_{DS} = 600 \text{ V}, \text{ T}_{C} = 125 ^{\circ}\text{C}$			100	μΑ
Igss	Gate-body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 25 V$			±10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	$V_{GS}$ = 10 V, $I_{D}$ = 5.5 A		0.35	0.38	Ω

#### Table 5: On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	580	-	pF
Coss	Output capacitance $V_{DS} = 100 \text{ V}, \text{ f} = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$		-	32	-	pF
Crss	Reverse transfer capacitance	V 66 – V V	-	1.1	-	pF
C <sub>oss eq.</sub> (1)	Equivalent output capacitance $V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V		-	120	-	pF
Rg	Intrinsic gate resistance f = 1 MHz open drain		-	6.6	-	Ω
Qg	Total gate charge $V_{DD} = 480 \text{ V}, I_D = 11 \text{ A},$		-	17	-	nC
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 10 V (see Figure 15: "Test circuit for gate charge	-	2.5	-	nC
$Q_{gd}$	Gate-drain charge	behavior")	-	9	-	nC

### Table 6: Dynamic

#### Notes:

 $^{(1)}C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}.$ 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 5.5 \text{ A},$	-	11	-	ns
tr	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ ( see Figure 14: "Test circuit	-	10	-	ns
t <sub>d(off)</sub>	Turn-off delay time	for resistive load switching	-	41	-	ns
t <sub>f</sub>	Fall time	times" and Figure 19: "Switching time waveform")	-	9.5	-	ns

#### Table 7: Switching times



#### Electrical characteristics

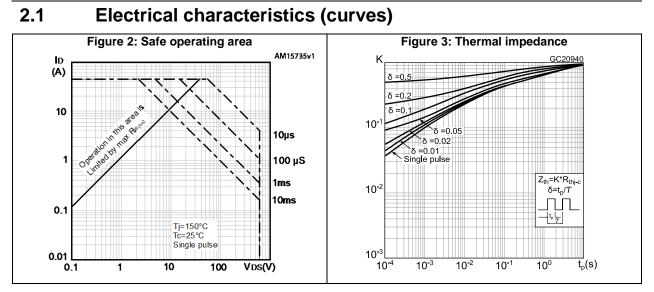
	Tal	ble 8: Source drain diode	•			r	
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Isd	Source-drain current		-		11	А	
I <sub>SDM</sub> <sup>(1)</sup>	I <sub>SDM</sub> <sup>(1)</sup> Source-drain current (pulsed)		-		44	А	
Vsd <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 11 A, V <sub>GS</sub> = 0 V	-		1.6	V	
trr	Reverse recovery time	I <sub>SD</sub> = 11 A, di/dt = 100 A/µs,	-	297		ns	
Qrr	Reverse recovery charge	V <sub>DD</sub> = 60 V ( see Figure 16: "Test circuit for inductive load	-	2.8		μC	
I <sub>RRM</sub>	Reverse recovery current	switching and diode recovery times")	-	18.5		А	
trr	Reverse recovery time	I <sub>SD</sub> = 11 A, di/dt = 100 A/µs,	-	394		ns	
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 \text{ °C}, \text{ (see}$ Figure 16: "Test circuit for	-	3.8		μC	
Irrm	Reverse recovery current	inductive load switching and diode recovery times" )	-	19		A	

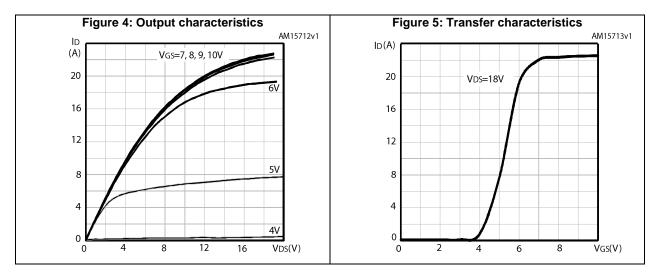
#### Notes:

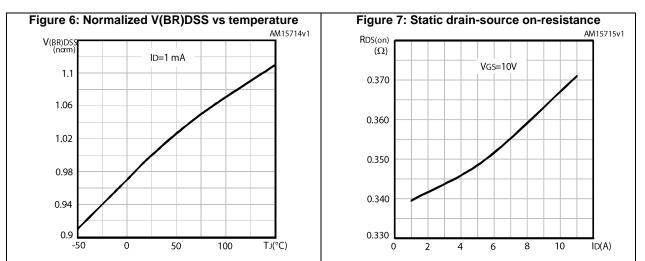
 $^{(1)}\mbox{Pulse}$  width limited by safe operating area.

 $^{(2)}\text{Pulsed:}$  pulse duration = 300 µs, duty cycle 1.5%.









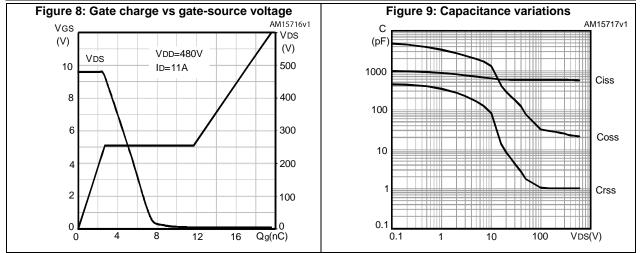
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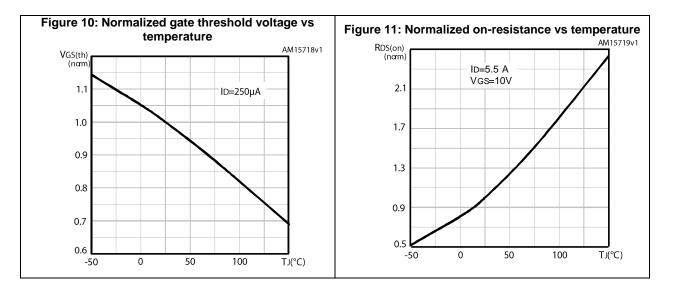


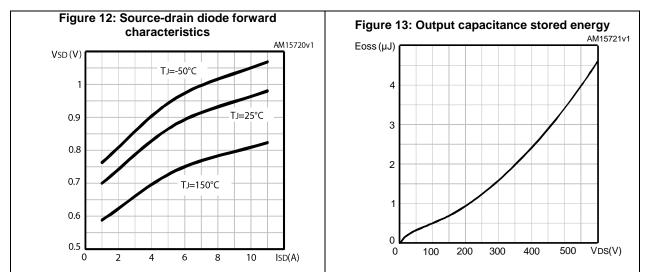
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#### **Electrical characteristics**

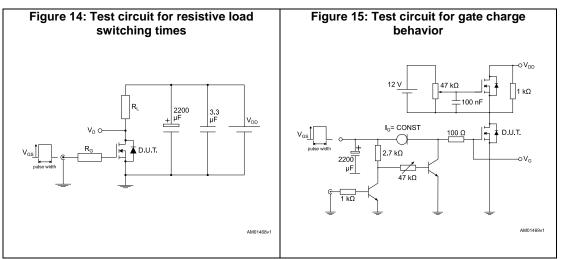


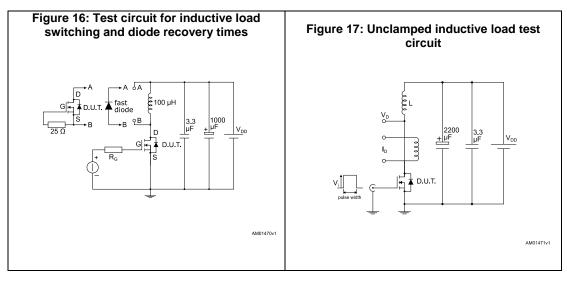


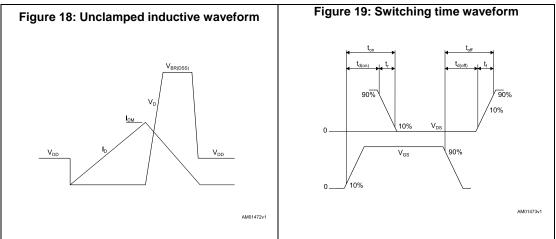


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### 3 Test circuit







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### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

### 4.1 TO-220FP package information

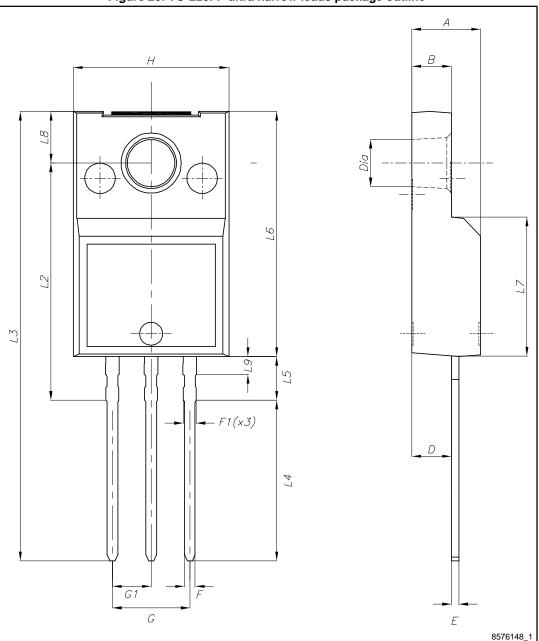


Figure 20: TO-220FP ultra narrow leads package outline



#### Package mechanical data

#### STFU13N60M2

nechanical data					
Та	ble 9: TO-220FP ultra nar	row leads mechanical of	lata		
Dim		mm			
Dim.	Min.	Тур.	Max.		
A	4.40		4.60		
В	2.50		2.70		
D	2.50		2.75		
E	0.45		0.60		
F	0.65		0.75		
F1	-		0.90		
G	4.95		5.20		
G1	2.40	2.54	2.70		
Н	10.00		10.40		
L2	15.10		15.90		
L3	28.50		30.50		
L4	10.20		11.00		
L5	2.50		3.10		
L6	15.60		16.40		
L7	9.00		9.30		
L8	3.20		3.60		
L9	-		1.30		
Dia.	3.00		3.20		



## 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
09-Mar-2015	1	Initial release
15-Sep-2015	2	Document status changed from preliminary to production data.



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